

Sheet 1 of 1Form PTO-1449
(REV. 1/06)US Dept. of Commerce
PATENT & TRADEMARK OFFICEATTY DOCKET NO.
117938APPLICATION NO.
10/743,719

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT(S)
Akihiko ITOFILING DATE
December 24, 2003GROUP
2672

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Name

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
XW	1	JP-A-2002-175039	06/21/2002	JAPAN	XX	XX

OTHER DOCUMENTS

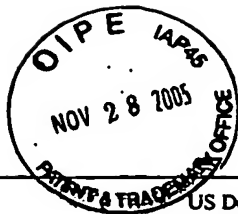
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER /Xiao Wu/

DATE CONSIDERED 07/26/2006

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: April 28, 2006

Sheet 1 of 1Form PTO-1449
(REV. 8-83)US Dept. of Commerce
PATENT & TRADEMARK OFFICEATTY DOCKET NO.
117938APPLICATION NO.
10/743,719

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT(S)
Akihiko ITOFILING DATE
December 24, 2003GROUP
2672

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS
XW	1	JP-A-06-051719 (w/English Translation & Abstract)	02/25/1994	JAPAN	 	
XW	2	JP-A-63-182695	07/27/1988	JAPAN	 	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER

/Xiao Wu/

DATE CONSIDERED

07/26/2006

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: November 28, 2005

Form PTO-1449 (REV. 8-83)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 117938	APPLICATION NO. New U.S. Application 10/743,719
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Akihiko ITO	
				FILING DATE December 24, 2003	GROUP 2629
U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS
FOREIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY	SUB CLASS
XW	1.	JP A 2001-100700 w/abstract & transl.	4/13/2001	JAPAN	
XW	2.	JP A 5-100629 w/abstract & transl.	4/23/1993	JAPAN	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)					
EXAMINER		/Xiao Wu/		DATE CONSIDERED	
				07/26/2005	
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.					

Date: December 24, 2003